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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
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10/734,420

12/11/2003

Winston Lee

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EXAMINER

TRIMMINGS, JOHN P

ART UNIT

PAPER NUMBER

2138

DATE MAILED: 04/27/2006

Please find below and/or attached an Office communication concerning this application or proceeding.

Office Action Summary

Application No.

10/734,420

Applicant(s)

LEE ET AL.

Examiner

John P. Trimmings

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2138

-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --
Period for Reply

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) OR THIRTY (30) DAYS, WHICHEVER IS LONGER, FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
- If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
- Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133). Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

Status

- 1) ☒ Responsive to communication(s) filed on 11 December 2003.
- 2a) ☐ This action is **FINAL**. 2b) ☒ This action is non-final.
- 3) ☐ Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

Disposition of Claims

- 4) ☒ Claim(s) 1-82 is/are pending in the application.
- 4a) Of the above claim(s) 28-82 is/are withdrawn from consideration.
- 5) ☐ Claim(s) _____ is/are allowed.
- 6) ☒ Claim(s) 1-82 is/are rejected.
- 7) ☐ Claim(s) _____ is/are objected to.
- 8) ☐ Claim(s) _____ are subject to restriction and/or election requirement.

Application Papers

- 9) ☒ The specification is objected to by the Examiner.
- 10) ☒ The drawing(s) filed on 11 December 2003 is/are: a) ☒ accepted or b) ☐ objected to by the Examiner.
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).
- 11) ☐ The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.

Priority under 35 U.S.C. § 119

- 12) ☐ Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
- a) ☐ All b) ☐ Some * c) ☐ None of:
1. ☐ Certified copies of the priority documents have been received.
 2. ☐ Certified copies of the priority documents have been received in Application No. _____.
 3. ☐ Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).

* See the attached detailed Office action for a list of the certified copies not received.

Attachment(s)

- | | |
|---|--|
| 1) <input checked="" type="checkbox"/> Notice of References Cited (PTO-892) | 4) <input checked="" type="checkbox"/> Interview Summary (PTO-413)
Paper No(s)/Mail Date. <u>04182006</u> . |
| 2) <input type="checkbox"/> Notice of Draftsperson's Patent Drawing Review (PTO-948) | 5) <input type="checkbox"/> Notice of Informal Patent Application (PTO-152) |
| 3) <input checked="" type="checkbox"/> Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08)
Paper No(s)/Mail Date <u>12/11/2003</u> . | 6) <input type="checkbox"/> Other: _____. |

DETAILED ACTION

Claims 1-82 are presented for examination.

Election/Restrictions

1. Restriction to one of the following inventions is required under 35 U.S.C. 121:
 - I. Claims 1-27, drawn to a memory testing apparatus, classified in class 714, subclass 718.
 - II. Claims 28-82, drawn to a method for reporting errors and replacement of redundant memory cells, classified in class 714, subclass 710.

The inventions are distinct, each from the other because of the following reasons:

2. Inventions I and II are related as subcombinations disclosed as usable together in a single combination. The subcombinations are distinct if they do not overlap in scope and are not obvious variants, and if it is shown that at least one subcombination is separately usable. In the instant case, subcombination I has separate utility such as testing a memory with an internal BIST using an external memory tester, whereas Group II is a method of reporting failed memory locations and cell replacement. See MPEP § 806.05(d).
3. Because these inventions are independent or distinct for the reasons given above and the inventions require a different field of search (see MPEP § 808.02), restriction for examination purposes as indicated is proper.

4. A telephone call was made to Michael Fogarty on 4/18/2006 to request an oral election to the above restriction requirement. The examiner and the applicant's attorney, Mr. Bernstein, discussed a restriction in the case. An election by the applicant was made in a return call to the examiner at 11:00 pm, where claims 1-27 were elected without traverse. The examiner will prosecute the case accordingly.

5. Applicant is reminded that upon the cancellation of claims to a non-elected invention, the inventorship must be amended in compliance with 37 CFR 1.48(b) if one or more of the currently named inventors is no longer an inventor of at least one claim remaining in the application. Any amendment of inventorship must be accompanied by a request under 37 CFR 1.48(b) and by the fee required under 37 CFR 1.17(i).

Priority

6. Applicant's claim for the benefit of a prior-filed application under 35 U.S.C. 119(e) is acknowledged.

Information Disclosure Statement

7. The information disclosure statement (IDS) submitted on 12/11/2003 is in compliance with the provisions of 37 CFR 1.97. Accordingly, the examiner has considered the information disclosure statement.

Specification

8. The disclosure is objected to because of the following informalities:

The examiner requests that page 8, paragraph [35] line 3 be corrected to recite,
“... goes to step ~~209~~ 210, which ...”.

The examiner requests that page 15, paragraph [55] line 1 be corrected to recite,
“... ... an associated a flag RGTX ...”.

Appropriate correction is required.

Claim Rejections - 35 USC § 102

The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless –

(e) the invention was described in (1) an application for patent, published under section 122(b), by another filed in the United States before the invention by the applicant for patent or (2) a patent granted on an application for patent by another filed in the United States before the invention by the applicant for patent, except that an international application filed under the treaty defined in section 351(a) shall have the effects for purposes of this subsection of an application filed in the United States only if the international application designated the United States and was published under Article 21(2) of such treaty in the English language.

9. Claims 1- 4, 7-9, 13-19 and 22-24 are rejected under 35 U.S.C. 102(e) as being anticipated by Au et al. (herein Au), U.S. Patent No. 6681359.

As per Claims 1 and 13 and 16:

Au teaches a memory testing System/means and method based on the System comprising: a first memory tester (FIG.2 72) with detecting means (column 3 lines 8-20) to detect failed location information from a memory (column 2 lines 30-47) at a first frequency (FIG.3 BIST_CLK 110); an interface (FIG.3 102, 104, 106, 108) in

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communication with the first memory tester (column 2 lines 30-32); and a second memory tester, in communication with the interface (column 3 lines 8-20), which receives the failed location information at a second frequency (FIG.3 TCK 106).

As per Claims 2 and 14 and 17:

Au further teaches the memory testing system/method/means according to claim 1/13/16, wherein the first frequency is the memory operating frequency (Abstract, column 3 lines 8-20).

As per Claims 3 and 15 and 18:

Au further teaches the memory testing system/method/means according to claim 1/13/16, wherein the second frequency is the working frequency of the second memory tester (Abstract, column 2 lines 48-67).

As per Claims 4 and 19:

Au further teaches the memory testing system/means according to claim 1/16, wherein the first memory tester comprises a built-in self-test (BIST) (FIG.2 72).

As per Claims 7 and 22:

Au further teaches the memory testing system/means according to claim 1/16, wherein the first frequency is higher than the second frequency (see Abstract).

As per Claims 8 and 23:

Au further teaches the memory testing system/means according to claim 1/16, wherein the interface comprises a general processor input/output (GPIO) interface (column 2 lines 18-26).

As per Claims 9 and 24:

Au further teaches the memory testing system/means according to claim 1/16, wherein the first memory tester asserts busy (RUN/TEST/IDLE, FIG.5 174) after receiving a test start signal (FIG.5 172).

Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negated by the manner in which the invention was made.

10. Claims 5, 10, 11-12, 20 and 25-27 are rejected under 35 U.S.C. 103(a) as being unpatentable over Au, as applied to claim 1 and 16 above, and further in view of Miner, U.S. Patent No. 6370661.

As per Claims 5 and 20:

Au fails to further teach the memory testing system/means according to claim 1/16, wherein the first memory tester comprises a CPU. But in the analogous art of Miner, such a feature is taught in FIG.5 where a Configurable BIST uses microprocessor 501 for testing memory 1-4. Miner, in column 2 lines 8-25, the advantage is a configurable self test capability within a microprocessor for testing memories at full speed without excessive chip tester vector memory. One with ordinary skill in the art at the time of the invention, motivated as suggested, would have found it

obvious to incorporate the microprocessor control of Miner with the test system of Au in order to decrease the chip tester vector overhead.

As per Claims 10 and 11 and 25 and 26:

Where Au fails, Miner further teaches the memory testing system/means according to claim 1/16, wherein the second memory tester sends N clocks of data strobes at the second frequency to the interface upon detection of a failed memory location (column 10 lines 61-67 and column 11 lines 1-4). Described here in Miner is a well known process of scanning data out of the result register according to IEEE Standard 1149.1, where scanning, under control of a clock and TMS, is executed a fixed number of times (N) as required by the register size. And in view of the motivation previously stated, the claims are rejected.

As per Claims 12 and 27:

Au further teaches the memory testing system/means according to claim 11/26, wherein the first memory tester asserts error (FIG.2 COMP STATUS) when a failed memory location is detected, and de-asserts error ("wait state", column 10 lines 44-48) before N-1 clocks of data strobes (FIG.5 188).

1. Claims 6 and 21 are rejected under 35 U.S.C. 103(a) as being unpatentable over Au, as applied to claim 1 and 16 above, and further in view of Teh et al. (herein Teh), U.S. Patent No. 7010736.

As per Claims 6 and 21:

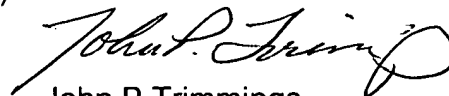
Au fails to further teach the memory testing system/means according to claim 1/16, wherein the second memory tester comprises an external memory tester. But in the analogous art of The, such a feature is disclosed in column 3 lines 46-52 and column 4 lines 30-46. And The, in column 4 lines 30-46, the advantage is stated as being an arrangement that allows a memory tester to test many dies simultaneously with integrated BISTs in the DUT chips. One with ordinary skill in the art at the time of the invention, motivated as suggested, would have found it obvious to incorporate the parallel test capabilities of The, including use of memory testers during test, with the test system of Au in order to increase DUT chip test throughput.

Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to John P. Trimmings whose telephone number is (571) 272-3830. The examiner can normally be reached on Monday through Thursday, 7:30 AM to 6:00 PM.

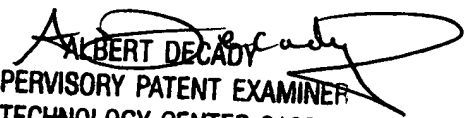
If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Albert DeCady can be reached on (571) 272-3819. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see <http://pair-direct.uspto.gov>. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).



John P Trimmings
Examiner
Art Unit 2138

jpt



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